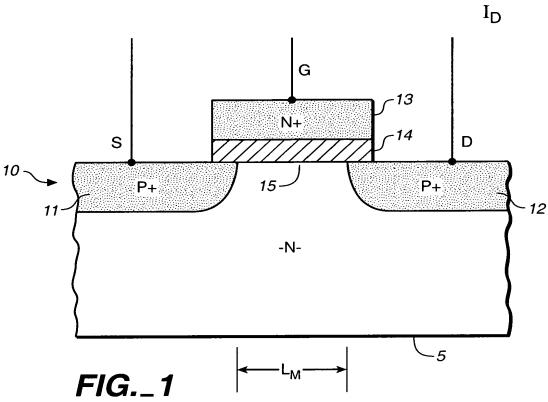
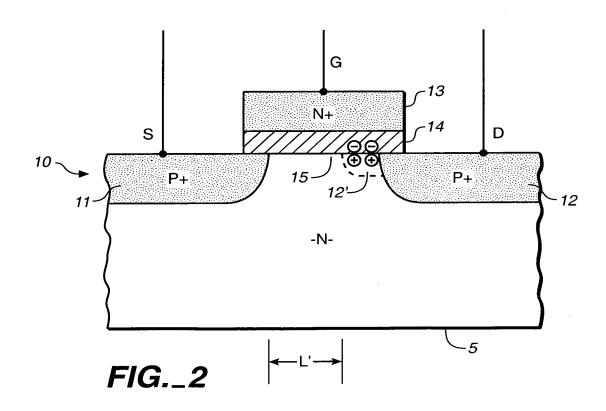
Appln. No.: 09/832,933 Docket No.: BTAT.002US1
Title: Hot Carrier Circuit Reliability Simulation
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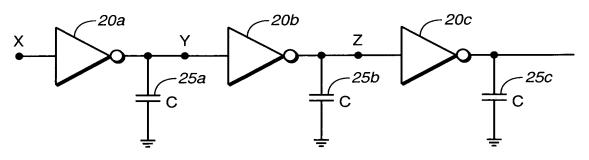


FIG._3

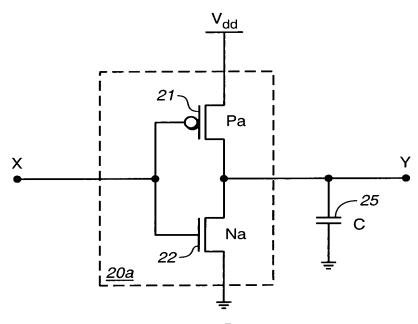
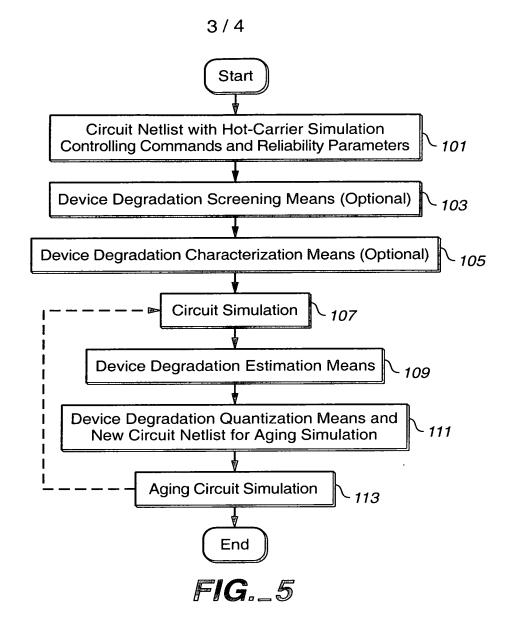


FIG._4

Appln. No.: 09/832,933 Docket No.: BTAT.002US1 Title: Hot Carrier Circuit Reliability Simulation Inventors: Wu et al.

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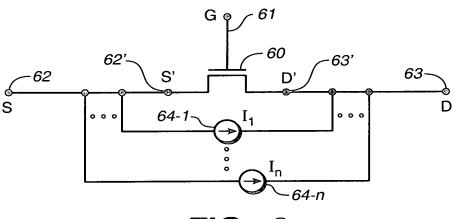


FIG._6

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